

PTO-1449 Information Disclosure Citation In an Application		Application No. To be Assigned 10/725,977		Applicant(s) Srinivasan (nmi) Chakravarthi et al.	
		Docket Number TI-36386 (032350.B538)		Group Art Unit To be Assigned 2822	
				Filing Date December 1, 2003	
U.S. PATENT DOCUMENTS					
		DOCUMENT NO.	DATE	NAME	CLASS
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NO.	DATE	COUNTRY	CLASS
		SUBCLASS	TRANSLATION		
			YES	NO	
NON-PATENT DOCUMENTS					
		NONPATENT DOCUMENT (Including Author, Title, Source, and Pertinent Pages)			DATE
JMS	A	Scott Thompson, "MOS Scaling: Transistor Challenges for the 21st Century – Abstract," Intel Technologies Journal, 3rd Quarter 1998, pp. 1-2			September 1998
JMS	B	Scott Thompson, "MOS Scaling: Transistor Challenges for the 21st Century – Oxide Scaling,," Intel Technologies Journal, 3rd Quarter 1998, pp. 1-9			September 1998
JMS	C	Scott Thompson, "MOS Scaling: Transistor Challenges for the 21st Century – Source Drain Engineering," Intel Technologies Journal, 3rd Quarter 1998, pp. 1-10			September 1998
JMS	D	Scott Thompson, "MOS Scaling: Transistor Challenges for the 21st Century – Channel Engineering," Intel Technologies Journal, 3rd Quarter 1998, pp. 1-11			September 1998
JMS	E	Scott Thompson, "MOS Scaling: Transistor Challenges for the 21st Century – Circuit and Device Interactions," Intel Technologies Journal, 3rd Quarter 1998, pp. 1-6			September 1998
JMS	F	Scott Thompson, "MOS Scaling: Transistor Challenges for the 21st Century – Alternate Device Options," Intel Technologies Journal, 3rd Quarter 1998, pp. 1- 5 5			September 1998
JMS	G	Scott Thompson, "MOS Scaling: Transistor Challenges for the 21st Century – Conclusion," Intel Technologies Journal, 3rd Quarter 1998, pp. 1			September 1998
EXAMINER				DATE CONSIDERED	
T. M. Thomas				04-11-05	
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.					

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